## Search Notes



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SEARCHED				
Class	Subclass	Date	Examiner	
375	240.13, 240.24	12/14/06	YH	
382	166, 234, 238, 250	12/14/06	YH	

Hung, Yubin

SEARCH NOTES		
Search Notes	Date	Examiner
EAST Text search (USPGPUB, USPAT, EPO, JPO, DERWENT, IBM-TDB)	12/14/06	YH
ACM	12/13/06	YH
IEEE Xplore	12/13/06	YH .
SPIE	12/13/06	YH

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